

Search Notes

Application/Control No.

10/816,979

Examiner

VanThu Nguyen

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

2824

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|--|-----------|----------|
| 365 | 185.05 185.06 x 189.01 189.09 | 11/2/2005 | VTN |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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| Same as | above | 11/2/2005 | VTN |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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| EAST Search (see print out history) | 11/2/2005 | VTN |
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